




<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>09883585</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>JEN ET AL.</p>
	<p>Examiner</p> <p>Nguyen, Thu Ha T</p>	<p>Art Unit</p> <p>2155</p>

Class	SubClass	Date	Examiner
709	203, 217, 223, 229, 245, 246	08/15/06	THN
707	3, 8, 9, 10, 101		
715	507-509, 734, 737-739, 745-747		
717	121	0815/06/	THN
U.S. Patent and Trademark Office		Part of Paper No.: 20060815	

Interference Searched 	Application/Control No. 09883585	Applicant(s)/Patent Under Reexamination JEN ET AL.
	Examiner Nguyen, Thu Ha T	Art Unit 2155

Class	SubClass	Date	Examiner
709	203	08/15/06	THN
709	223		
707	3		
707	9		
707	10		
715	507		
715	508	08/15/06	THN

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Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
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Notes	Date	Examiner
East, Derwent, JPO, EPO, USPG-Pub, Inventor name, assignee name search	08/15/06	THN
Double patenting search		
NPL search, Google, Hotbot, IEEE, ACM search		
EIC search, Fast and Focus, Plus search		
Consult with Primary Khanh Dinh	08/15/06	THN
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